

**Notice of References Cited**

Application/Control No.

10/511,589

Applicant(s)/Patent Under

Reexamination

OHASHI ET AL.

Examiner

Deborah Yee

Art Unit

1793

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,527,883	03-2003	Kawabe et al.	148/580
*	B US-4,889,567	12-1989	Fujiwara et al.	148/598
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	English abstract of Japanese patent 2004277759, Kuroda, Takeshi et al., October 7, 2004.
V	English abstract of Japanese patent 402285026, Takahashi, Toshihiko et al., November 22, 1990.
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.